

Search Notes

Application/Control No.

10/061,719

Examiner

Binh C. Tat

Applicant(s)/Patent under
Reexamination

TEIG ET AL.

Art Unit

2825

SEARCHED

Class	Subclass	Date	Examiner
716	1-18	3/30/2005	BT
703	2,14-16	3/30/2005	BT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
716	1-18	3/30/2005	BT
703	2,14-16	3/30/2005	BT

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST SEARCH	3/30/2005	BT
IEEE	P	l